

**Search Notes**

Application/Control No.

10/629,634

Examiner

TUAN A. PHAM

Applicant(s)/Patent under  
Reexamination

IWAI ET AL.

Art Unit

2618

**SEARCHED**

Class	Subclass	Date	Examiner
455	575.1	10/23/2007	PHAM
	575.5		
	575.6		
	575.7	10/23/2007	PHAM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR